

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	4	10/730388	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 15:46
S2	231	702/183.ccls. and @pd>"20060201"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/12 14:40
S3	67	702/183.ccls. and @pd>"20060201" and @ad<"20030627"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 14:43
S4	48	((fabricat\$4 manufactur\$4 semiconduc\$4) with (process method)) and (pattern with recogni\$8) and (feature with extract\$4) and (mass centroid geometric Hu) and (test with data) and @ad<"20030627"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/12 15:57
S5	45	((fabricat\$4 manufactur\$4 semiconduc\$4) with (process méthode)) and (pattern with recogni\$8) and (feature with extract\$4) and (mass centroid geometric Hu) and (test with data) and @ad<"20030627" and (component ic chip asic)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 08:10
S6	30	paul with buxton	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 08:11
S7	25	paul with buxton.in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:31

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S8	40	((eric paul) with tabor).in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:32
S9	33	((martin miguelanez) with emilio).in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:34
S10	3	(ali with zalzala).in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:39
S11	205	(feature with extract\$8) and (pattern with recogni\$8) and ((fabricat\$4 manufactur\$4 semiconduc\$4) with (process method)) and (mass centroid geometr\$4 Hu) and @ad<"20030627"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 14:46
S12	162	(feature with extract\$8) and (pattern with recogni\$8) and ((fabricat\$4 manufactur\$4 semiconduc\$4) with (process method)) and (mass centroid geometr\$4 Hu) and @ad<"20030627" and (component ic chip asic)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:52
S13	15	(feature with extract\$8) and (pattern with recogni\$8) and ((fabricat\$4 manufactur\$4 semiconduc\$4) with (process method)) and (mass centroid geometr\$4 Hu) and @ad<"20030627" and ((component ic chip asic) same test same data)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 10:52
S14	0	702/183.ccls. and (test and data and component and fabrication and process and pattern and feature and (mass centroid geometr\$4 Hu)).clm.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/13 14:42

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S15	2	(test and data and component and fabrication and process and pattern and feature and (mass centroid geometr\$4 Hu)).clm.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/13 13:30
S16	3217	((700/26,47,48,89) or (706/15-44)).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/12/13 14:42
S17	2759	S16 and @ad<"20030627"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 14:43
S18	14	S17 and (feature with extract\$8) and (pattern with recogni\$8) and ((fabricat\$4 manufatur\$4 semiconduc\$4) with (process method))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 14:46
S19	2	"6539106".pn.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 15:53
S20	35	("5301248" "5401972" "5455870" "5493116" "5495535" "5502306" "5578821" "6072897" "6122397" "6122398" "6169816" "6225815").PN. OR ("6539106").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/13 15:54
S21	2	"5130936".pn.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/12/13 15:56
S22	86	("4620286" "4644479" "4649515" "4796206" "4841456" "4866635" "4918620" "4970725" "4979124").PN. OR ("5130936").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/13 15:56